

Notice of References Cited	Application/Control No. 10/590,882		Applicant(s)/Patent Under Reexamination KITAYOSHI ET AL.	
	Examiner RUFUS POINT		Art Unit 2612	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,761,934 A	09-1973	Terakawa, Koichi	343/752
*	B	US-4,159,470 A	06-1979	Strojny et al.	714/4.4
*	C	US-4,537,515 A	08-1985	Dinger et al.	368/202
*	D	US-4,942,393 A	07-1990	Waraksa et al.	340/5.62
*	E	US-5,572,190 A	11-1996	Ross et al.	340/541
*	F	US-5,726,630 A	03-1998	Marsh et al.	340/10.2
*	G	US-5,777,561 A	07-1998	Chieu et al.	340/10.32
*	H	US-5,826,175 A	10-1998	Schmidt et al.	455/77
*	I	US-5,986,570 A	11-1999	Black et al.	340/10.2
*	J	US-5,995,019 A	11-1999	Chieu et al.	340/10.32
*	K	US-6,137,422 A	10-2000	Hahn et al.	340/10.1
*	L	US-6,150,921 A	11-2000	Werb et al.	340/10.1
*	M	US-6,236,314 B1	05-2001	Smith et al.	340/572.7

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/590,882		Applicant(s)/Patent Under Reexamination KITAYOSHI ET AL.	
	Examiner RUFUS POINT		Art Unit 2612	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,466,131 B1	10-2002	Tuttle et al.	340/572.7
*	B	US-6,661,336 B1	12-2003	Atkins et al.	340/10.2
*	C	US-6,784,787 B1	08-2004	Atkins et al.	340/10.4
*	D	US-6,942,155 B1	09-2005	Stewart et al.	235/487
*	E	US-7,006,014 B1	02-2006	Henty, David L.	341/22
*	F	US-2006/0132302 A1	06-2006	Stilp, Louis A.	340/539.22
*	G	US-7,084,769 B2	08-2006	Bauer et al.	340/572.7
*	H	US-7,151,436 B2	12-2006	Fischer et al.	340/10.1
*	I	US-RE40,111 E	02-2008	Sanderford et al.	375/141
*	J	US-7,339,481 B2	03-2008	Duron, Mark William	340/572.7
*	K	US-7,408,456 B2	08-2008	Whitesmith et al.	340/500
*	L	US-7,616,113 B2	11-2009	Ayachitula et al.	340/539.13
*	M	US-7,612,652 B2	11-2009	Stewart et al.	340/10.34

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/590,882		Applicant(s)/Patent Under Reexamination KITAYOSHI ET AL.	
	Examiner RUFUS POINT		Art Unit 2612	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,741,956 B1	06-2010	Nysen, Paul A.	340/10.41
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.